

1048,576 WORD × 4 BIT DYNAMIC RAM

**PRELIMINARY**

**DESCRIPTION**

The TC514402AP/AJ/ASJ/AZ is the new generation dynamic RAM organized 1,048,576 words by 4 bits. The TC514402AP/AJ/ASJ/AZ utilizes TOSHIBA's CMOS Silicon gate process technology as well as advanced circuit techniques to provide wide operating margins, both internally and to the system user. Multiplexed address inputs permit the TC514402AP/AJ/ASJ/AZ to be packaged in a standard 20 pin plastic DIP, 26/20 pin plastic SOJ (300/350mil) and 20 pin plastic ZIP. The package size provides high system bit densities and is compatible with widely available automated testing and insertion equipment. System oriented features include single power supply of 5V±10% tolerance, direct interfacing capability with high performance logic families such as Schottky TTL.

**FEATURES**

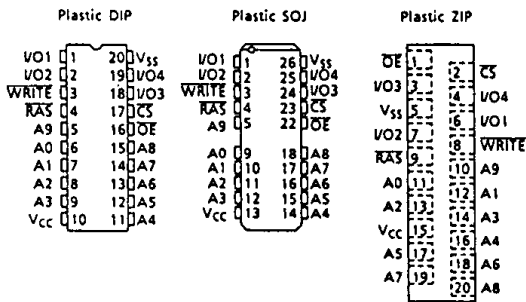
- 1,048,576 word by 4 bit organization
- Fast access time and cycle time

	TC514402AP/AJ/ASJ/AZ - 70/ - 80/ - 10/		
t <sub>RAC</sub> RAS Access Time	70ns	80ns	100ns
t <sub>AA</sub> Column Address Access Time	35ns	40ns	50ns
t <sub>CAC</sub> CS Access Time	20ns	20ns	25ns
t <sub>RC</sub> Cycle Time	130ns	150ns	180ns
t <sub>SC</sub> Static Column Mode Cycle Time	40ns	45ns	55ns

**PIN NAMES**

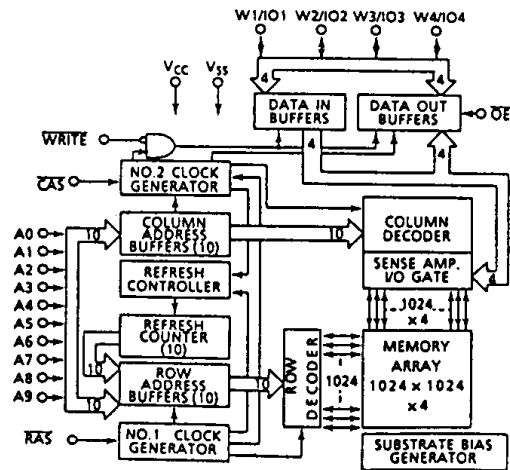
Symbol	Function	IO	Power
A0~A9	Address Inputs	OE	Output Enable
RAS	Row Address Strobe	I/O1~I/O4	Data Input/Output
CS	Chip Select	V <sub>CC</sub>	Power (+5V)
WRITE	Read/Write Input	V <sub>SS</sub>	Ground

**PIN CONNECTION (TOP VIEW)**



- Single power supply of 5V±10% with a built-in V<sub>BB</sub> generator
- Low Power
  - 550mW MAX. Operating (TC514402AP/AJ/ASJ/AZ - 70)
  - 468mW MAX. Operating (TC514402AP/AJ/ASJ/AZ - 80)
  - 413mW MAX. Operating (TC514402AP/AJ/ASJ/AZ - 10)
  - 5.5mW MAX. Standby
- Output unlatched at cycle end allows two-dimensional chip selection
- Read-Modify-Write, CS before RAS refresh, RAS-only refresh, Hidden refresh, Static Column Mode and Test Mode capability
- All inputs and outputs TTL Compatible
- 1024 refresh cycles/16ms
- Package
  - TC514402AP : DIP20-P-300C
  - TC514402AJ : SOJ26-P-350
  - TC514402ASJ : SOJ26-P-300A
  - TC514402AZ : ZIP20-P-400A

**BLOCK DIAGRAM**



# TC514402AP/AJ/ASJ/AZ-70, TC514402AP/AJ/ASJ/AZ-80 TC514402AP/AJ/ASJ/AZ-10

## ABSOLUTE MAXIMUM RATINGS

ITEM	SYMBOL	RATING	UNITS	NOTES
Input Voltage	$V_{IN}$	-1~7	V	1
Output Voltage	$V_{OUT}$	-1~7	V	1
Power Supply Voltage	$V_{CC}$	-1~7	V	1
Operating Temperature	$T_{OPR}$	0~70	°C	1
Storage Temperature	$T_{STG}$	-55~150	°C	1
Soldering Temperature · Time	$T_{SOLDER}$	260 · 10	°C · sec	1
Power Dissipation	$P_D$	700	mW	1
Short Circuit Output Current	$I_{OUT}$	50	mA	1

## RECOMMENDED DC OPERATING CONDITIONS ( $T_a = 0 \sim 70^\circ\text{C}$ )

SYMBOL	PARAMETER	MIN.	TYP.	MAX.	UNIT	NOTES
$V_{CC}$	Supply Voltage	4.5	5.0	5.5	V	2
$V_{IH}$	Input High Voltage	2.4	-	6.5	V	2
$V_{IL}$	Input Low Voltage	-1.0	-	0.8	V	2

# TC514402AP/AJ/ASJ/AZ-70, TC514402AP/AJ/ASJ/AZ-80 TC514402AP/AJ/ASJ/AZ-10

## DC ELECTRICAL CHARACTERISTICS ( $V_{CC} = 5V \pm 10\%$ , $T_a = 0 \sim 70^\circ\text{C}$ )

SYMBOL	PARAMETER	MIN.	MAX.	UNITS	NOTES	
$I_{CC1}$	OPERATING CURRENT Average Power Supply Operating Current ( $\overline{RAS}$ , $\overline{CS}$ , Address Cycling: $t_{RC} = t_{RC}$ MIN.)	TC514402AP/AJ/ASJ/AZ-70	-	100	mA	3, 4 5
		TC514402AP/AJ/ASJ/AZ-80	-	85		
		TC514402AP/AJ/ASJ/AZ-10	-	75		
$I_{CC2}$	STANDBY CURRENT Power Supply Standby Current ( $\overline{RAS} = \overline{CS} = V_{IH}$ )	-	2	mA		
$I_{CC3}$	$\overline{RAS}$ ONLY REFRESH CURRENT Average Power Supply Current, $\overline{RAS}$ Only Mode ( $\overline{RAS}$ Cycling, $\overline{CS} = V_{IH}$ ; $t_{RC} = t_{RC}$ MIN.)	TC514402AP/AJ/ASJ/AZ-70	-	100	mA	3, 5
		TC514402AP/AJ/ASJ/AZ-80	-	85		
		TC514402AP/AJ/ASJ/AZ-10	-	75		
$I_{CC4}$	STATIC COLUMN MODE CURRENT Average Power Supply Current, STATIC COLUMN Mode ( $\overline{RAS} = \overline{CS} = V_{IL}$ , Address Cycling: $t_{SC} = t_{SC}$ MIN.)	TC514402AP/AJ/ASJ/AZ-70	-	85	mA	3, 4 5
		TC514402AP/AJ/ASJ/AZ-80	-	75		
		TC514402AP/AJ/ASJ/AZ-10	-	70		
$I_{CC5}$	STANDBY CURRENT Power Supply Standby Current ( $\overline{RAS} = \overline{CS} = V_{CC} - 0.2V$ )	-	1	mA		
$I_{CC6}$	$\overline{CS}$ BEFORE $\overline{RAS}$ REFRESH CURRENT Average Power Supply Current, $\overline{CS}$ Before $\overline{RAS}$ Mode ( $\overline{RAS}$ , $\overline{CS}$ Cycling: $t_{RC} = t_{RC}$ MIN.)	TC514402AP/AJ/ASJ/AZ-70	-	100	mA	3, 5
		TC514402AP/AJ/ASJ/AZ-80	-	85		
		TC514402AP/AJ/ASJ/AZ-10	-	75		
$I_{I(L)}$	INPUT LEAKAGE CURRENT Input Leakage Current, any input ( $0V \leq V_{IN} \leq 6.5V$ , All Other Pins Not Under Test = $0V$ )	-10	10	$\mu\text{A}$		
$I_{O(L)}$	OUTPUT LEAKAGE CURRENT ( $D_{OUT}$ is disabled, $0V \leq V_{OUT} \leq 5.5V$ )	-10	10	$\mu\text{A}$		
$V_{OH}$	OUTPUT LEVEL Output "H" Level Voltage ( $I_{OUT} = -5\text{mA}$ )	2.4	-	V		
$V_{OL}$	OUTPUT LEVEL Output "L" Level Voltage ( $I_{OUT} = 4.2\text{mA}$ )	-	0.4	V		

# TC514402AP/AJ/ASJ/AZ-70, TC514402AP/AJ/ASJ/AZ-80 TC514402AP/AJ/ASJ/AZ-10

## ELECTRICAL CHARACTERISTICS AND RECOMMENDED AC OPERATING CONDITIONS

( $V_{CC} = 5V \pm 10\%$ ,  $T_a = 0 \sim 70^\circ C$ ) (Notes 6, 7, 8)

SYMBOL	PARAMETER	TC514402AP/ AJ/ASJ/AZ-70		TC514402AP/ AJ/ASJ/AZ-80		TC514402AP/ AJ/ASJ/AZ-10		UNIT	NOTES
		MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
$t_{RC}$	Random Read or Write Cycle Time	130	-	150	-	180	-	ns	
$t_{RMW}$	Read-Modify-Write Cycle Time	185	-	205	-	245	-	ns	
$t_{SC}$	Static Column Mode Cycle Time	40	-	45	-	55	-	ns	
$t_{SRMW}$	Static Column Mode Read-Modify-Write Cycle Time	100	-	110	-	135	-	ns	
$t_{RAC}$	Access Time from $\overline{RAS}$	-	70	-	80	-	100	ns	9,14 15
$t_{CAC}$	Access Time from $\overline{CS}$	-	20	-	20	-	25	ns	9,14
$t_{AA}$	Access Time from Column Address	-	35	-	40	-	50	ns	9,15
$t_{ALW}$	Access Time from Last Write	-	65	-	75	-	95	ns	9,16
$t_{CLZ}$	$\overline{CS}$ to output in Low-Z	0	-	0	-	0	-	ns	9
$t_{OFF}$	Output Buffer Turn-off Delay	0	20	0	20	0	20	ns	10
$t_{AOH}$	Output Data Hold Time from Column Address	5	-	5	-	5	-	ns	
$t_{OW}$	Output Data Enable Time from $\overline{WRITE}$	-	20	-	20	-	30	ns	
$t_T$	Transition Time (Rise and Fall)	3	50	3	50	3	50	ns	8
$t_{RP}$	$\overline{RAS}$ Precharge Time	50	-	60	-	70	-	ns	
$t_{RAS}$	$\overline{RAS}$ Pulse Width	70	10,000	80	10,000	100	10,000	ns	
$t_{RASC}$	$\overline{RAS}$ Pulse Width (Static Column Mode)	70	200,000	80	200,000	100	200,000	ns	
$t_{RSH}$	$\overline{CS}$ to $\overline{RAS}$ Hold Time	20	-	20	-	25	-	ns	
$t_{CSH}$	$\overline{RAS}$ to $\overline{CS}$ Hold Time	70	-	80	-	100	-	ns	
$t_{CS}$	$\overline{CS}$ Pulse Width	20	10,000	20	10,000	25	10,000	ns	
$t_{CSC}$	$\overline{CS}$ Pulse Width (Static Column Mode)	20	200,000	20	200,000	25	200,000	ns	
$t_{RCD}$	$\overline{RAS}$ to $\overline{CS}$ Delay Time	20	50	20	60	25	75	ns	14
$t_{RAD}$	$\overline{RAS}$ to Column Address Delay Time	15	35	15	40	20	50	ns	15
$t_{CRP}$	$\overline{CS}$ to $\overline{RAS}$ Precharge Time	5	-	5	-	10	-	ns	
$t_{CP}$	$\overline{CS}$ Precharge Time	10	-	10	-	10	-	ns	
$t_{ASR}$	Row Address Set-Up Time	0	-	0	-	0	-	ns	
$t_{RAH}$	Row Address Hold Time	10	-	10	-	15	-	ns	
$t_{ASC}$	Column Address Set-Up Time	0	-	0	-	0	-	ns	
$t_{CAH}$	Column Address Hold Time	15	-	15	-	20	-	ns	
$t_{AR}$	Column Address Hold Time referenced to $\overline{RAS}$ (READ CYCLE)	85	-	95	-	115	-	ns	
$t_{RAL}$	Column Address to $\overline{RAS}$ Lead Time	35	-	40	-	50	-	ns	
$t_{AH}$	Column Address Hold Time referenced to $\overline{RAS}$ Rise	5	-	5	-	10	-	ns	17

**TC514402AP/AJ/ASJ/AZ-70, TC514402AP/AJ/ASJ/AZ-80  
TC514402AP/AJ/ASJ/AZ-10**

SYMBOL	PARAMETER	TC514402AP/ AJ/ASJ/AZ-70		TC514402AP/ AJ/ASJ/AZ-80		TC514402AP/ AJ/ASJ/AZ-10		UNITS	NOTES
		MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
t <sub>LWAD</sub>	Last Write to Column Address Delay Time	20	30	20	35	25	45	ns	16
t <sub>AHLW</sub>	Last Write to Column Address Hold Time	65	-	75	-	95	-	ns	
t <sub>RCS</sub>	Read Command Set-up Time referenced to $\overline{CS}$	0	-	0	-	0	-	ns	
t <sub>RCH</sub>	Read Command Hold Time referenced to $\overline{CS}$	0	-	0	-	0	-	ns	11
t <sub>RRH</sub>	Read Command Hold Time referenced to $\overline{RAS}$	0	-	0	-	0	-	ns	11
t <sub>WCH</sub>	Write Command Hold Time (Output Data Disable)	15	-	15	-	20	-	ns	13
t <sub>WP</sub>	Write Command Pulse Width	15	-	15	-	20	-	ns	
t <sub>WI</sub>	Write Command Inactive Time	10	-	10	-	10	-	ns	
t <sub>RWL</sub>	Write Command to $\overline{RAS}$ Lead Time	20	-	20	-	25	-	ns	
t <sub>CWL</sub>	Write Command to $\overline{CS}$ Lead Time	20	-	20	-	25	-	ns	
t <sub>DS</sub>	Data-In Set-Up Time	0	-	0	-	0	-	ns	12
t <sub>DH</sub>	Data-In Hold Time	15	-	15	-	20	-	ns	12
t <sub>REF</sub>	Refresh Period	-	16	-	16	-	16	ms	
t <sub>WCS</sub>	Write Command Set-UP Time (Output Data Disable)	0	-	0	-	0	-	ns	13
t <sub>CWD</sub>	$\overline{CS}$ to WRITE Delay Time (READ-MODIFY-WRITE CYCLE)	50	-	50	-	60	-	ns	13
t <sub>RWD</sub>	$\overline{RAS}$ to WRITE Delay Time (READ-MODIFY-WRITE Cycle)	100	-	110	-	135	-	ns	13
t <sub>AWD</sub>	Column Address to WRITE Delay Time	65	-	70	-	85	-	ns	13
t <sub>CSR</sub>	$\overline{CS}$ Set-Up Time( $\overline{CS}$ before $\overline{RAS}$ )	5	-	5	-	5	-	ns	
t <sub>CHR</sub>	$\overline{CS}$ Hold Time( $\overline{CS}$ before $\overline{RAS}$ )	15	-	15	-	20	-	ns	
t <sub>RPC</sub>	$\overline{RAS}$ to $\overline{CS}$ Precharge Time	0	-	0	-	0	-	ns	
t <sub>CPT</sub>	$\overline{CS}$ Precharge Time( $\overline{CS}$ before $\overline{RAS}$ Counter Test Cycle)	40	-	40	-	50	-	ns	
t <sub>ROH</sub>	$\overline{RAS}$ Hold Time referenced to $\overline{OE}$	10	-	10	-	20	-	ns	
t <sub>OEA</sub>	$\overline{OE}$ Access Time	-	20	-	20	-	25	ns	
t <sub>OED</sub>	$\overline{OE}$ to Data Delay	20	-	20	-	25	-	ns	
t <sub>OEZ</sub>	Output Buffer turn off Delay Time from $\overline{OE}$	0	20	0	20	0	20	ns	10
t <sub>OEH</sub>	$\overline{OE}$ Command Hold Time	20	-	20	-	25	-	ns	

TC514402AP/AJ/ASJ/AZ-70, TC514402AP/AJ/ASJ/AZ-80  
 TC514402AP/AJ/ASJ/AZ-10

SYMBOL	PARAMETER	TC514402AP/ AJ/ASJ/AZ-70		TC514402AP/ AJ/ASJ/AZ-80		TC514402AP/ AJ/ASJ/AZ-10		UNIT	NOTES
		MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
t <sub>WTS</sub>	Write Command Set-Up Time	10	-	10	-	10	-	ns	
t <sub>WTH</sub>	Write Command Hold Time	10	-	10	-	10	-	ns	
t <sub>WRP</sub>	WRITE to RAS Precharge Time	10	-	10	-	10	-	ns	
t <sub>WRH</sub>	WRITE to RAS Hold Time	10	-	10	-	10	-	ns	

# TC514402AP/AJ/ASJ/AZ-70, TC514402AP/AJ/ASJ/AZ-80 TC514402AP/AJ/ASJ/AZ-10

ELECTRICAL CHARACTERISTICS AND RECOMMENDED AC OPERATING CONDITIONS IN THE TEST MODE ( $V_{CC} = 5V \pm 10\%$ ,  $T_a = 0 \sim 70^\circ\text{C}$ ) (Notes 6, 7, 8)

SYMBOL	PARAMETER	TC514402AP/ AJ/ASJ/AZ-70		TC514402AP/ AJ/ASJ/AZ-80		TC514402AP/ AJ/ASJ/AZ-10		UNIT	NOTES
		MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
$t_{RC}$	Random Read or Write Cycle Time	135	-	155	-	185	-	ns	
$t_{RMW}$	Read-Modify-Write Cycle Time	190	-	210	-	250	-	ns	
$t_{SC}$	Static Column Mode Cycle Time	45	-	50	-	60	-	ns	
$t_{SRMW}$	Static Column Mode Read-Modify-Write Cycle Time	105	-	115	-	140	-	ns	
$t_{RAC}$	Access Time from $\overline{CS}$	-	75	-	85	-	105	ns	9,14 15
$t_{CAC}$	Access Time from $\overline{CS}$	-	25	-	25	-	30	ns	9,14
$t_{AA}$	Access Time from Column Address	-	40	-	45	-	50	ns	9,15
$t_{ALW}$	Access Time from Last Write	-	70	-	80	-	100	ns	9,16
$t_{RAS}$	$\overline{RAS}$ Pulse Width	75	10,000	85	10,000	105	10,000	ns	
$t_{RASC}$	$\overline{RAS}$ Pulse Width (Static Column Mode)	75	200,000	85	200,000	105	200,000	ns	
$t_{RSH}$	$\overline{RAS}$ Hold Time	25	-	25	-	30	-	ns	
$t_{CSH}$	$\overline{CS}$ Hold Time	75	-	85	-	105	-	ns	
$t_{CS}$	$\overline{CS}$ Pulse Width	25	10,000	25	10,000	30	10,000	ns	
$t_{CSC}$	$\overline{CS}$ Pulse Width (Static Column Mode)	25	200,000	25	200,000	30	200,000	ns	
$t_{RAL}$	Column Address to $\overline{RAS}$ Lead Time	40	-	45	-	55	-	ns	
$t_{CWD}$	$\overline{CS}$ to $\overline{WRITE}$ Delay Time	60	-	60	-	70	-	ns	13
$t_{RWD}$	$\overline{RAS}$ to $\overline{WRITE}$ Delay Time	105	-	115	-	140	-	ns	13
$t_{AWD}$	Column Address to $\overline{WRITE}$ Delay Time	70	-	75	-	90	-	ns	13
$t_{OEA}$	$\overline{OE}$ Access Time	-	25	-	25	-	30	ns	
$t_{OED}$	$\overline{OE}$ to Data Delay	25	-	25	-	30	-	ns	
$t_{OEH}$	$\overline{OE}$ Command Hold Time	25	-	25	-	30	-	ns	

CAPACITANCE ( $V_{CC} = 5V \pm 10\%$ ,  $f = 1\text{MHz}$ ,  $T_a = 0 \sim 70^\circ\text{C}$ )

SYMBOL	PARAMETER	MIN.	MAX.	UNIT
$C_{I1}$	Input Capacitance (A0~A9)	-	5	pF
$C_{I2}$	Input Capacitance ( $\overline{RAS}$ , $\overline{CS}$ , $\overline{WRITE}$ , $\overline{OE}$ )	-	7	pF
$C_O$	Input/Output Capacitance (I/O1~I/O4)	-	7	pF

# TC514402AP/AJ/ASJ/AZ-70, TC514402AP/AJ/ASJ/AZ-80 TC514402AP/AJ/ASJ/AZ-10

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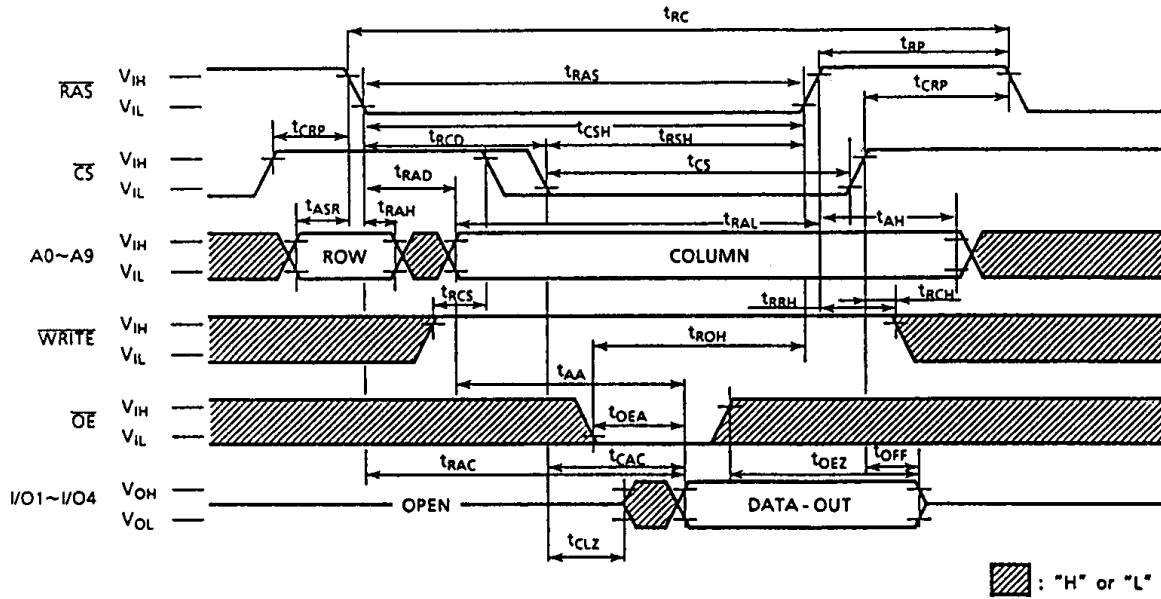
## NOTES:

1. Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device.
2. All voltages are referenced to  $V_{SS}$ .
3.  $ICC_1$ ,  $ICC_3$ ,  $ICC_4$ ,  $ICC_6$  depend on cycle rate.
4.  $ICC_1$ ,  $ICC_4$  depend on output loading. Specified values are obtained with the output open.
5. Column address can be changed once or less while  $\overline{RAS} = V_{IL}$  and  $\overline{CS} = V_{IH}$ .
6. An initial pause of 200 $\mu$ s is required after power-up followed by 8  $\overline{RAS}$  only refresh cycles before proper device operation is achieved. In case of using internal refresh counter, a minimum of 8  $\overline{CS}$  before  $\overline{RAS}$  refresh cycles instead of 8  $\overline{RAS}$  refresh cycles are required.
7. AC measurements assume  $t_T = 5$ ns.
8.  $V_{IH}$  (min.) and  $V_{IL}$  (max.) are reference levels for measuring timing of input signals.
9. Measured with a load equivalent to 2 TTL loads and 100pF.
10.  $t_{OFF}$  (max.) and  $t_{OEZ}$  (max.) define the time at which the output achieves the open circuit condition and are not referenced to output voltage levels.
11. Either  $t_{RCH}$  or  $t_{RRH}$  must be satisfied for a read cycle.
12. These parameters are referenced to  $\overline{CS}$  leading edge in early write cycles and to  $\overline{WRITE}$  leading edge in Read-Modify-Write cycles.
13.  $t_{WCS}$ ,  $t_{RWD}$ ,  $t_{CWD}$  and  $t_{AWD}$  are not restrictive operating parameters. They are included in the data sheet as electrical characteristics only. If  $t_{WCS} \geq t_{WCS}(\text{min.})$ , the cycle is an early write cycle and the data out pin will remain open circuit (high impedance) through the entire cycle; If  $t_{RWD} \geq t_{RWD}(\text{min.})$ ,  $t_{CWD} \geq t_{CWD}(\text{min.})$  and  $t_{AWD} \geq t_{AWD}(\text{min.})$  the cycle is a Read-Modify-Write cycle and the data out will contain data read from the selected cell: If neither of the above sets of conditions is satisfied, the condition of the data out (at access time) is indeterminate.
14. Operation within the  $t_{RCD}(\text{max.})$  limit insures that  $t_{RAC}(\text{max.})$  can be met.  
 $t_{RCD}(\text{max.})$  is specified as a reference point only: If  $t_{RCD}$  is greater than the specified  $t_{RCD}(\text{max.})$  limit, then access time is controlled by  $t_{CAC}$ .
15. Operation within the  $t_{RAD}(\text{max.})$  limit insures that  $t_{RAC}(\text{max.})$  can be met.  
 $t_{RAD}(\text{max.})$  is specified as a reference point only: If  $t_{RAD}$  is greater than the specified  $t_{RAD}(\text{max.})$  limit, then access time is controlled by  $t_{AA}$ .
16. Operation within the  $t_{LWAD}(\text{max.})$  limit insures that  $t_{ALW}(\text{max.})$  can be met.  
 $t_{LWAD}(\text{max.})$  is specified as a reference point only: If  $t_{RAD}$  is greater than the specified  $t_{LWAD}(\text{max.})$  limit, then access time is controlled by  $t_{AA}$ .
17.  $t_{AH}$  is the condition to latch column address ewhen  $\overline{RAS}$  has risen up.

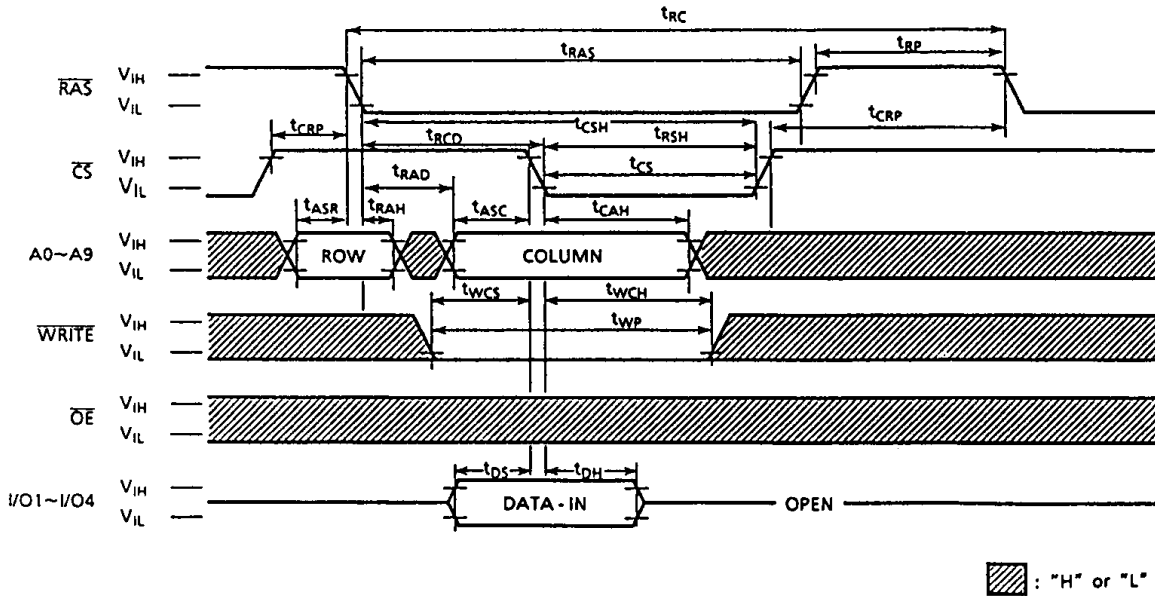


TC514402AP/AJ/ASJ/AZ-70, TC514402AP/AJ/ASJ/AZ-80  
TC514402AP/AJ/ASJ/AZ-10

READ CYCLE

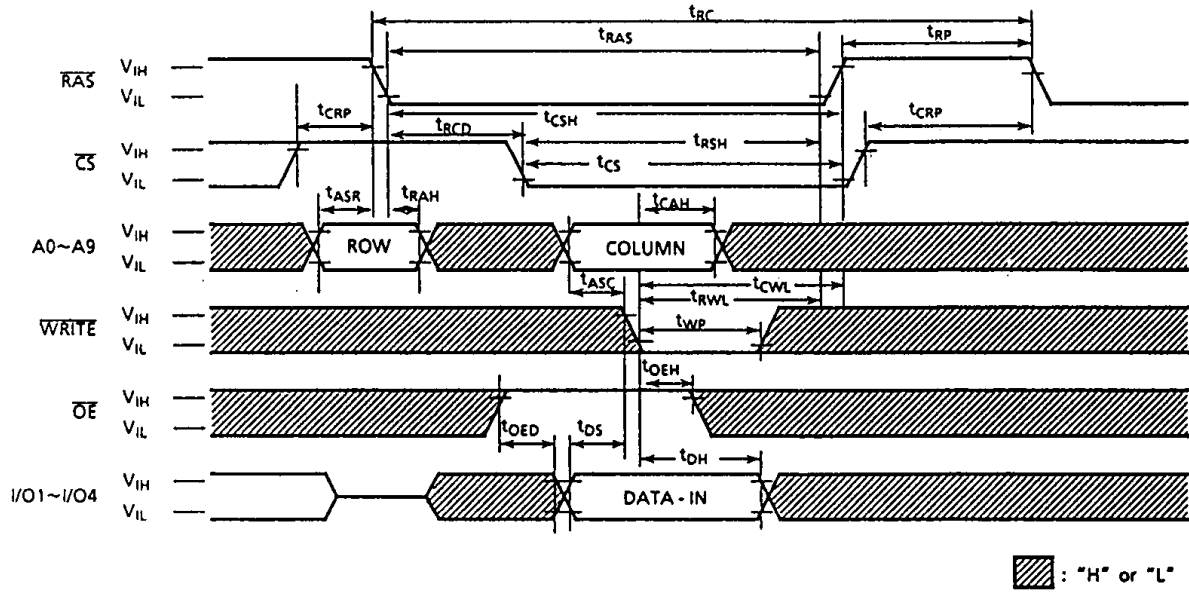


WRITE CYCLE (EARLY WRITE)

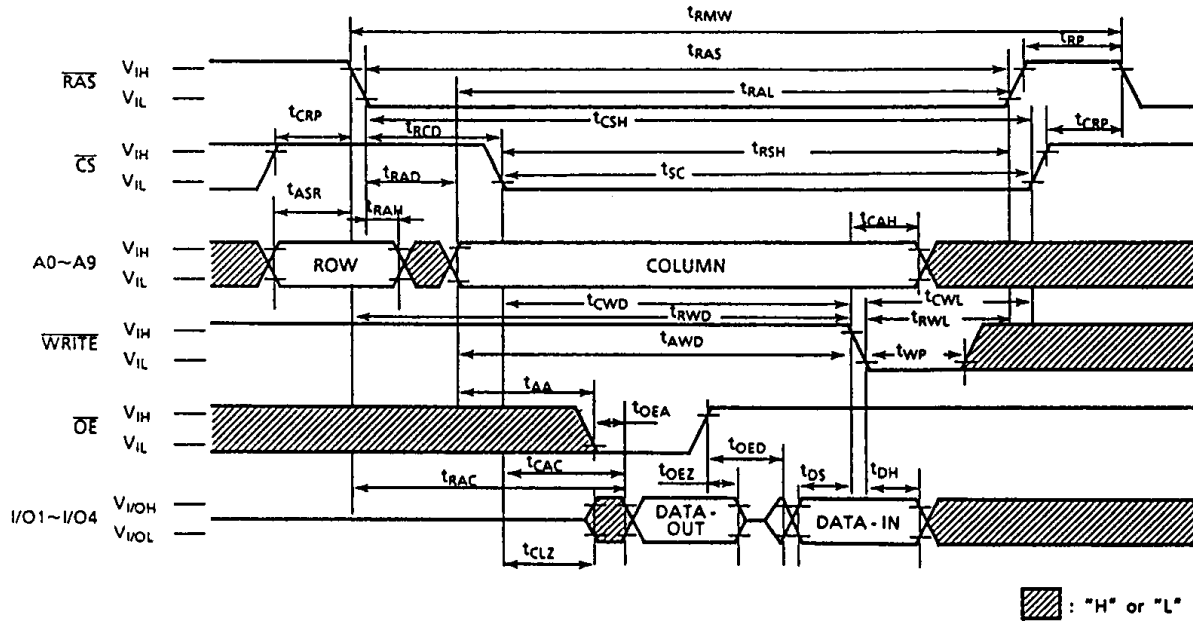


# TC514402AP/AJ/ASJ/AZ-70, TC514402AP/AJ/ASJ/AZ-80 TC514402AP/AJ/ASJ/AZ-10

## WRITE CYCLE ( $\overline{OE}$ CONTROLLED WRITE)

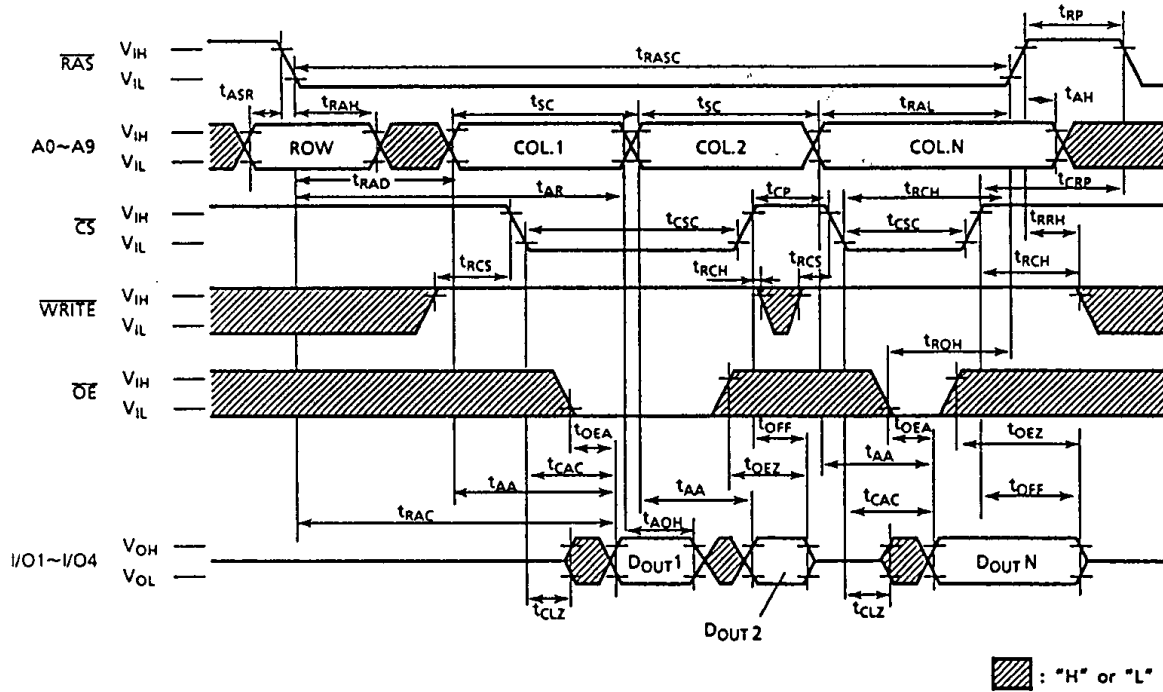


## READ - MODIFY - WRITE CYCLE



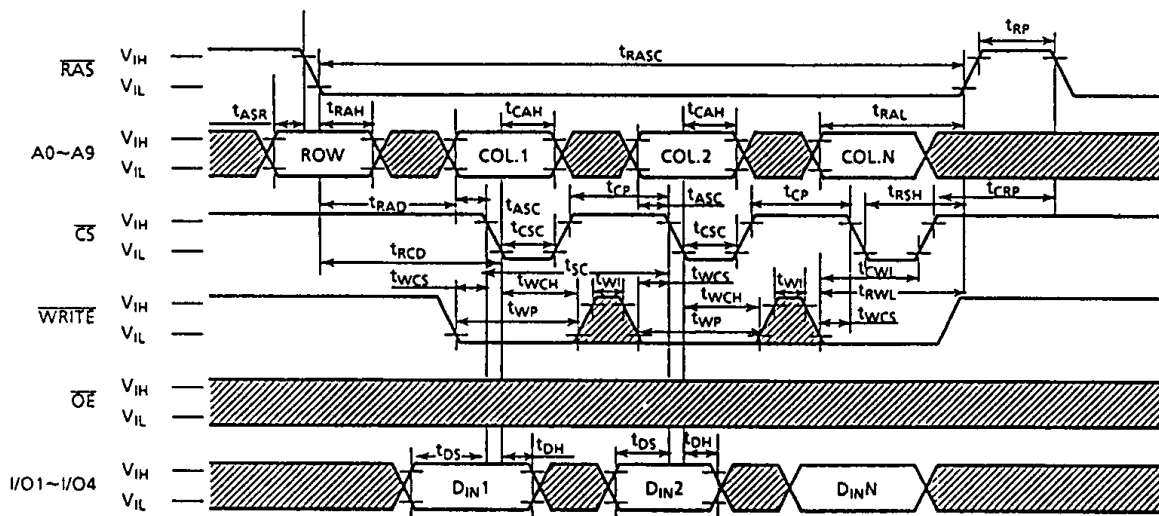
TC514402AP/AJ/ASJ/AZ-70, TC514402AP/AJ/ASJ/AZ-80  
 TC514402AP/AJ/ASJ/AZ-10

STATIC COLUMN MODE READ CYCLE

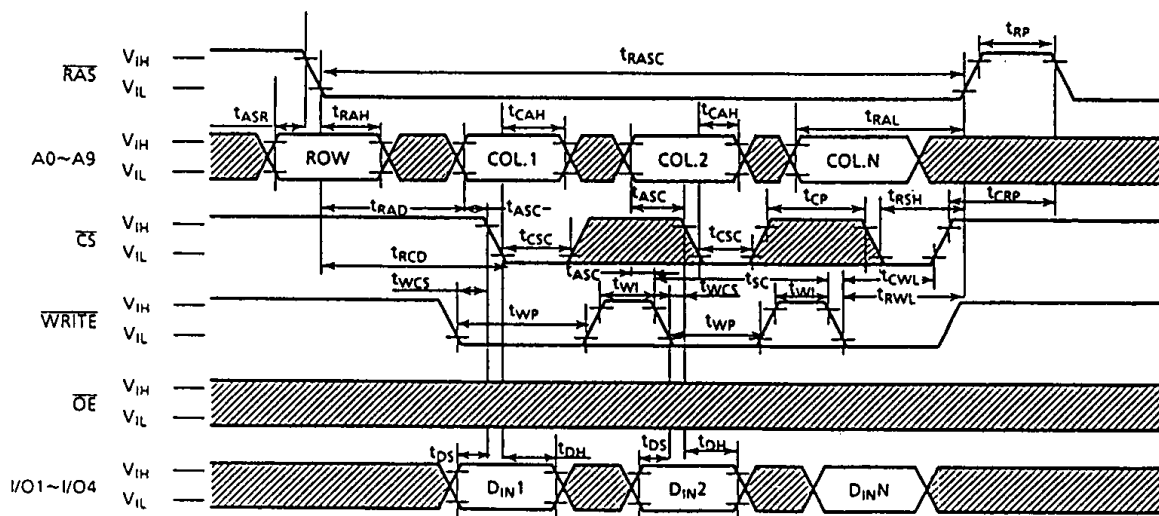


# TC514402AP/AJ/ASJ/AZ-70, TC514402AP/AJ/ASJ/AZ-80 TC514402AP/AJ/ASJ/AZ-10

STATIC COLUMN MODE WRITE CYCLE (EARLY WRITE)

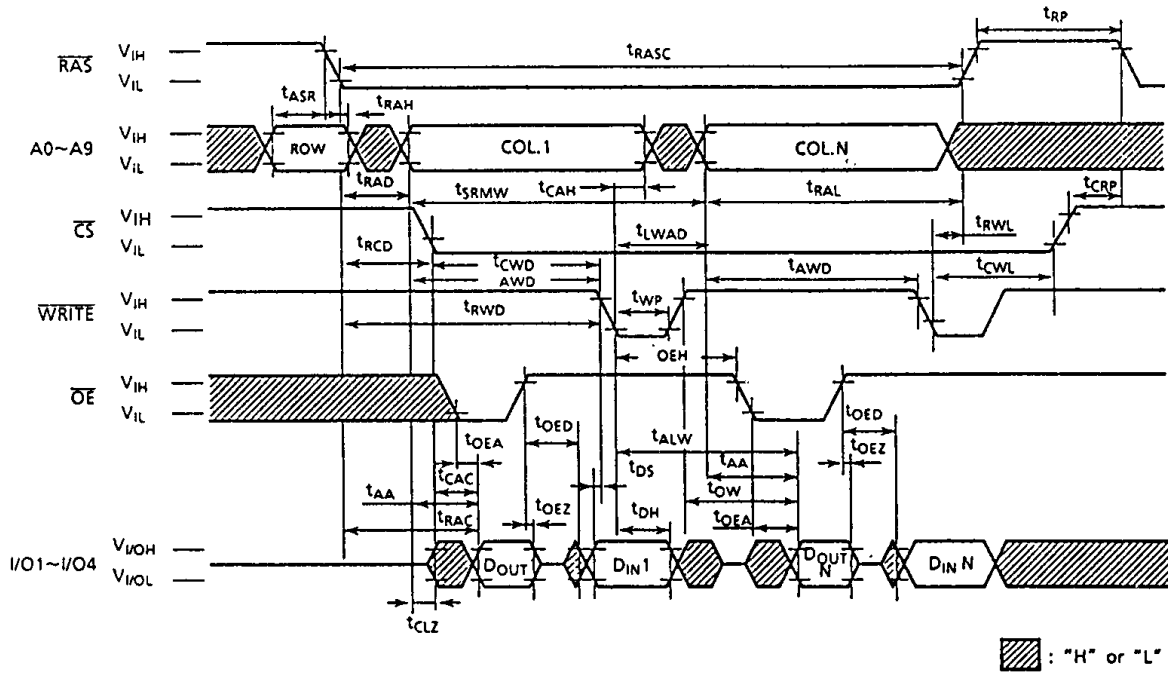


STATIC COLUMN MODE WRITE CYCLE (EARLY WRITE)



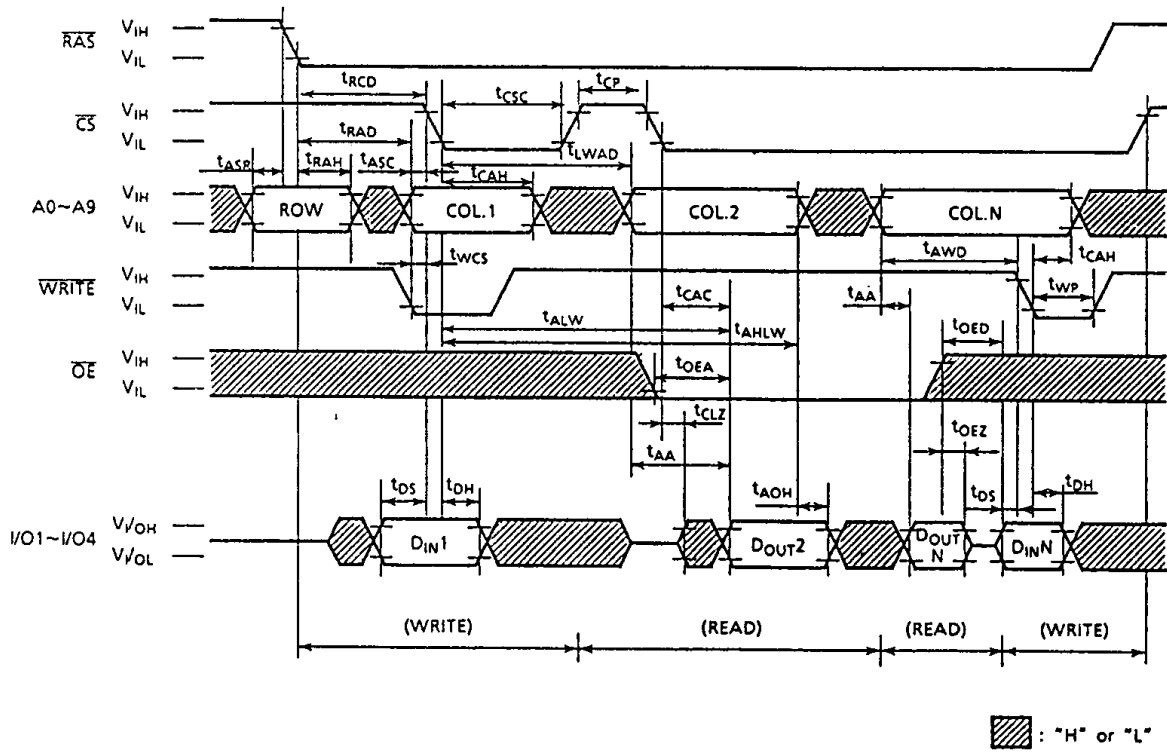
TC514402AP/AJ/ASJ/AZ-70, TC514402AP/AJ/ASJ/AZ-80  
TC514402AP/AJ/ASJ/AZ-10

STATIC COLUMN MODE READ - MODIFY - WRITE CYCLE



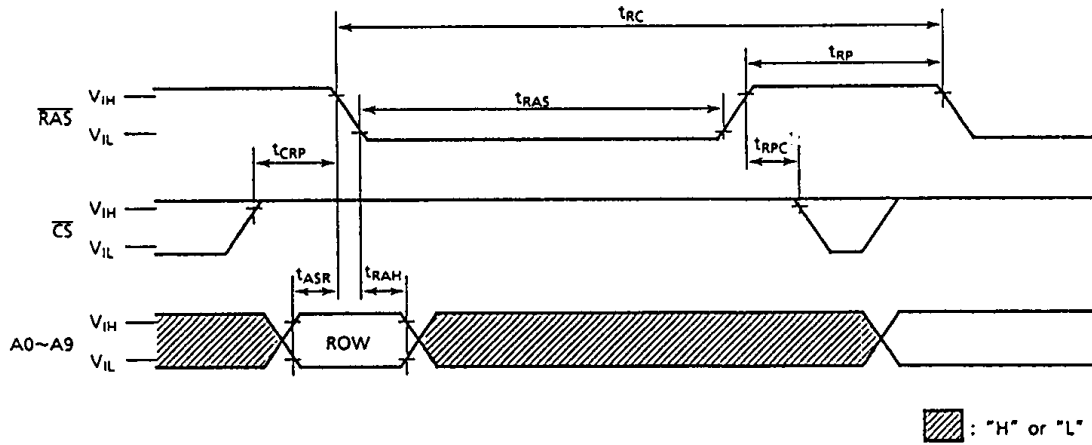
TC514402AP/AJ/ASJ/AZ-70, TC514402AP/AJ/ASJ/AZ-80  
 TC514402AP/AJ/ASJ/AZ-10

STATIC COLUMN MODE READ/WRITE MIXED CYCLE



TC514402AP/AJ/ASJ/AZ-70, TC514402AP/AJ/ASJ/AZ-80  
 TC514402AP/AJ/ASJ/AZ-10

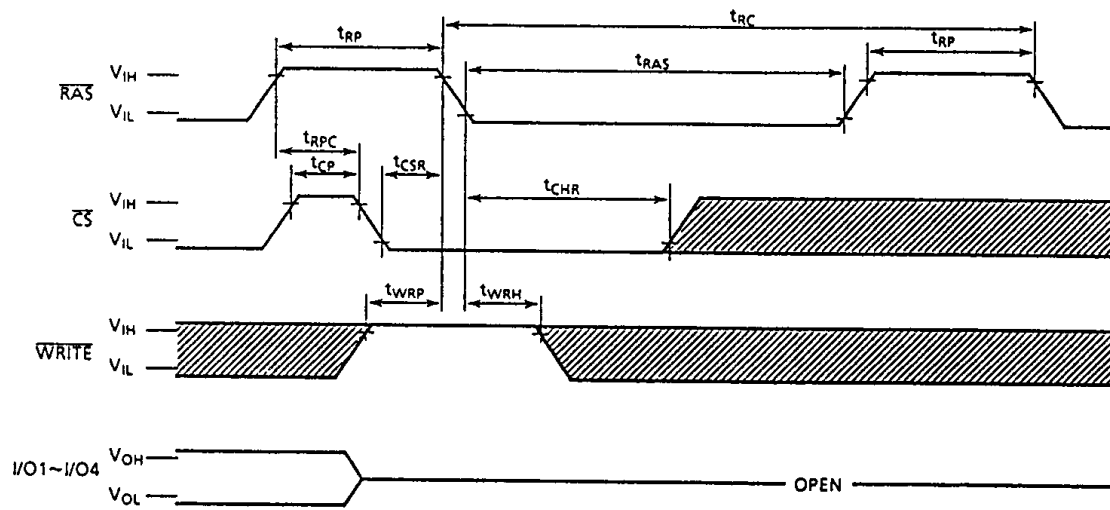
RAS ONLY REFRESH CYCLE



Note: WRITE, OE="H" or "L"

TC514402AP/AJ/ASJ/AZ-70, TC514402AP/AJ/ASJ/AZ-80  
 TC514402AP/AJ/ASJ/AZ-10

CS BEFORE RAS REFRESH CYCLE



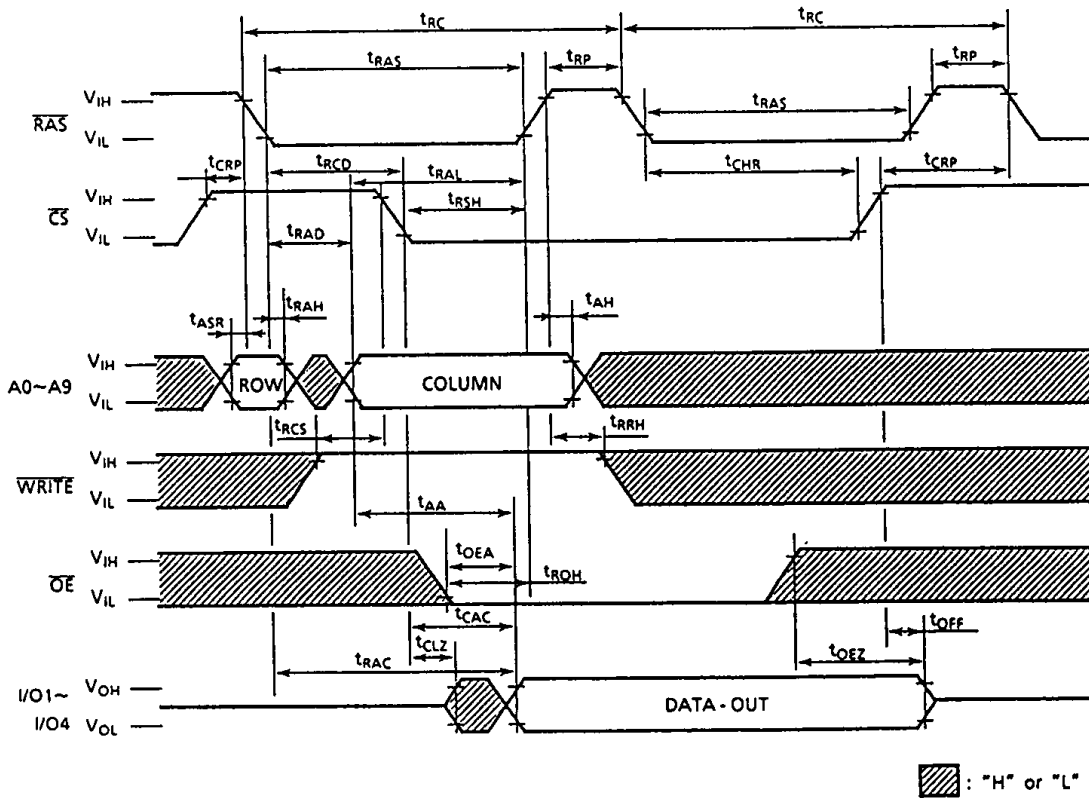
Note:  $\overline{OE}$ , A0~A9 = "H" or "L"

: "H" or "L"



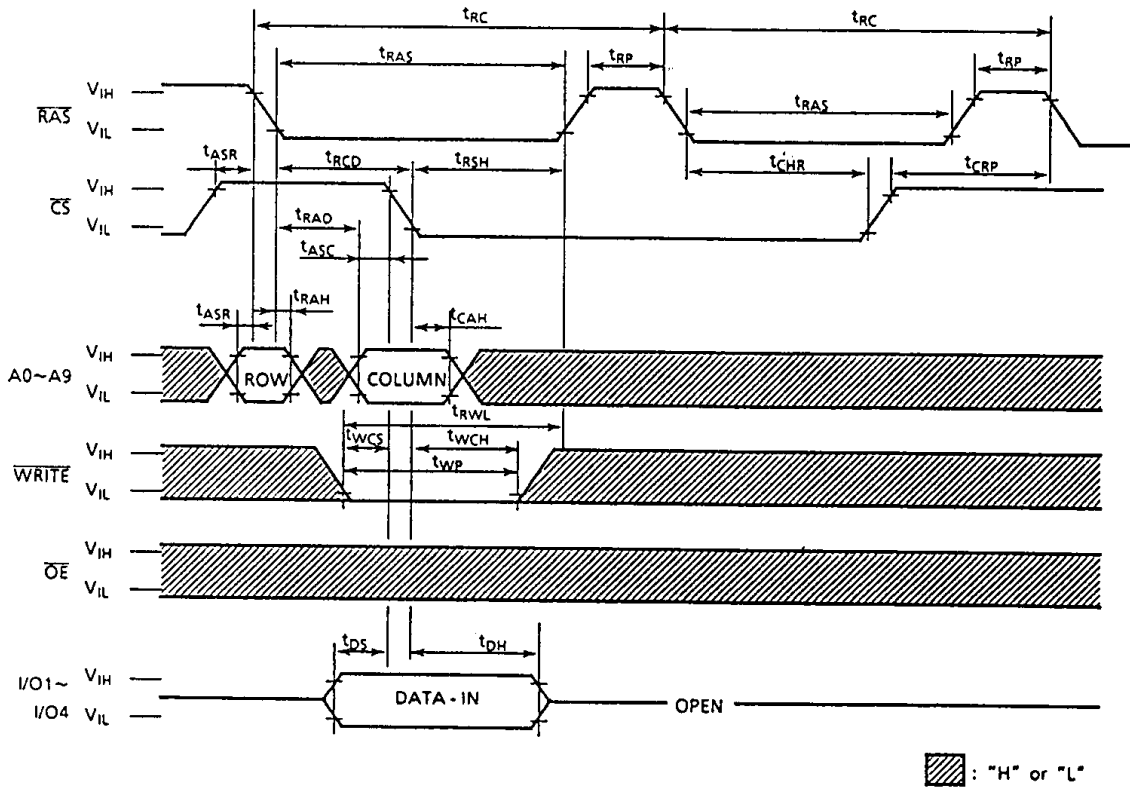
TC514402AP/AJ/ASJ/AZ-70, TC514402AP/AJ/ASJ/AZ-80  
 TC514402AP/AJ/ASJ/AZ-10

HIDDEN REFRESH CYCLE (READ)



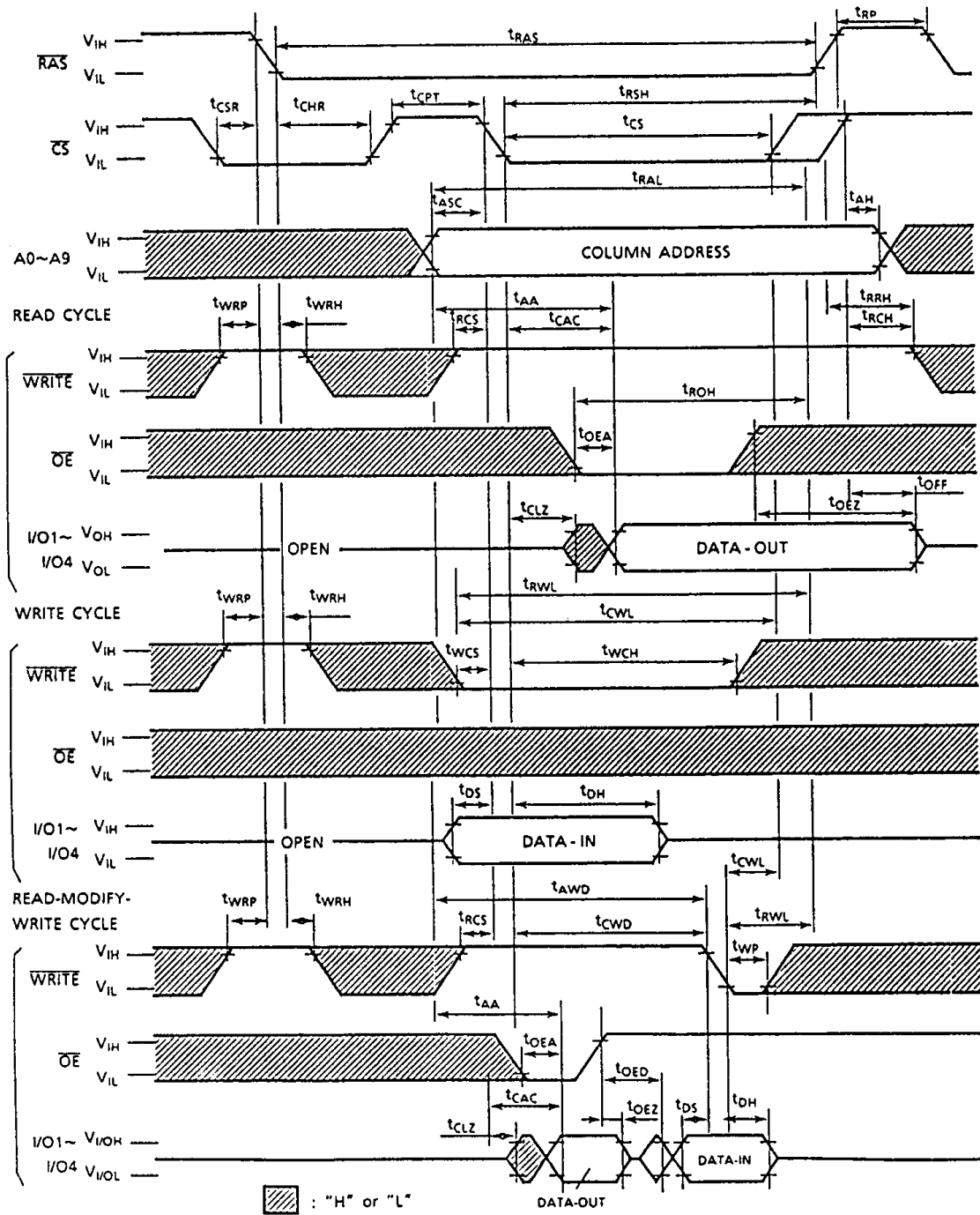
TC514402AP/AJ/ASJ/AZ-70, TC514402AP/AJ/ASJ/AZ-80  
 TC514402AP/AJ/ASJ/AZ-10

HIDDEN REFRESH CYCLE (WRITE)



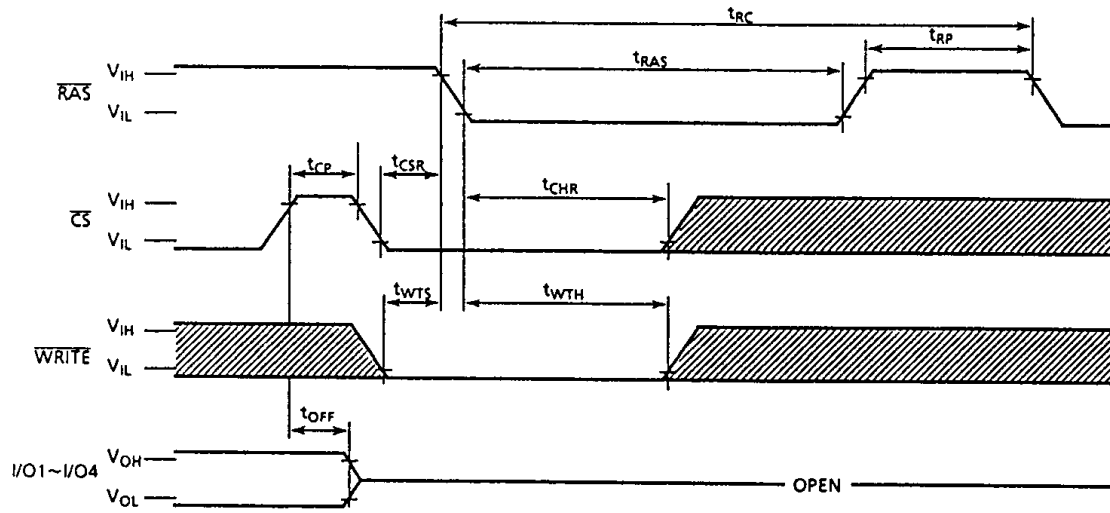
TC514402AP/AJ/ASJ/AZ-70, TC514402AP/AJ/ASJ/AZ-80  
 TC514402AP/AJ/ASJ/AZ-10

CS BEFORE RAS REFRESH COUNTER TEST CYCLE



TC514402AP/AJ/ASJ/AZ-70, TC514402AP/AJ/ASJ/AZ-80  
 TC514402AP/AJ/ASJ/AZ-10

WRITE,  $\overline{CS}$  BEFORE  $\overline{RAS}$  REFRESH CYCLE



Note:  $\overline{OE}$ , A0~A9 = "H" or "L"

▨ : "H" or "L"

# TC514402AP/AJ/ASJ/AZ-70, TC514402AP/AJ/ASJ/AZ-80 TC514402AP/AJ/ASJ/AZ-10

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## TEST MODE

The TC514402AP/AJ/ASJ/AZ is the RAM organized 1,048,576 words by 4 bits, it is internally organized 524,288 words by 8 bits. In "Test Mode", data are written into 8 sectors in parallel and retrieved the same way. A0C is not used. If, upon reading, two bits on one I/O pin are equal (all "1"s or "0"s), the I/O pin indicates a "1". If they were not equal, the I/O pin would indicate a "0". Fig. 1 shows the block diagram of TC514402AP/AJ/ASJ/AZ. In "Test Mode", the 1M×4 DRAM can be tested as if it were a 512K×4 DRAM.

"WRITE, CS Before RAS Refresh Cycle" puts the device into "Test Mode". And "CS Before RAS Refresh Cycle" or "RAS Only Refresh Cycle" put it back into "Normal Mode". In the Test Mode, "WRITE, CS Before RAS Refresh Cycle" performs the refresh operation with the internal refresh address counter. The "Test Mode" function reduces test times (1/2 in case of N test pattern).

# TC514402AP/AJ/ASJ/AZ-70, TC514402AP/AJ/ASJ/AZ-80 TC514402AP/AJ/ASJ/AZ-10

## BLOCK DIAGRAM IN THE TEST MODE

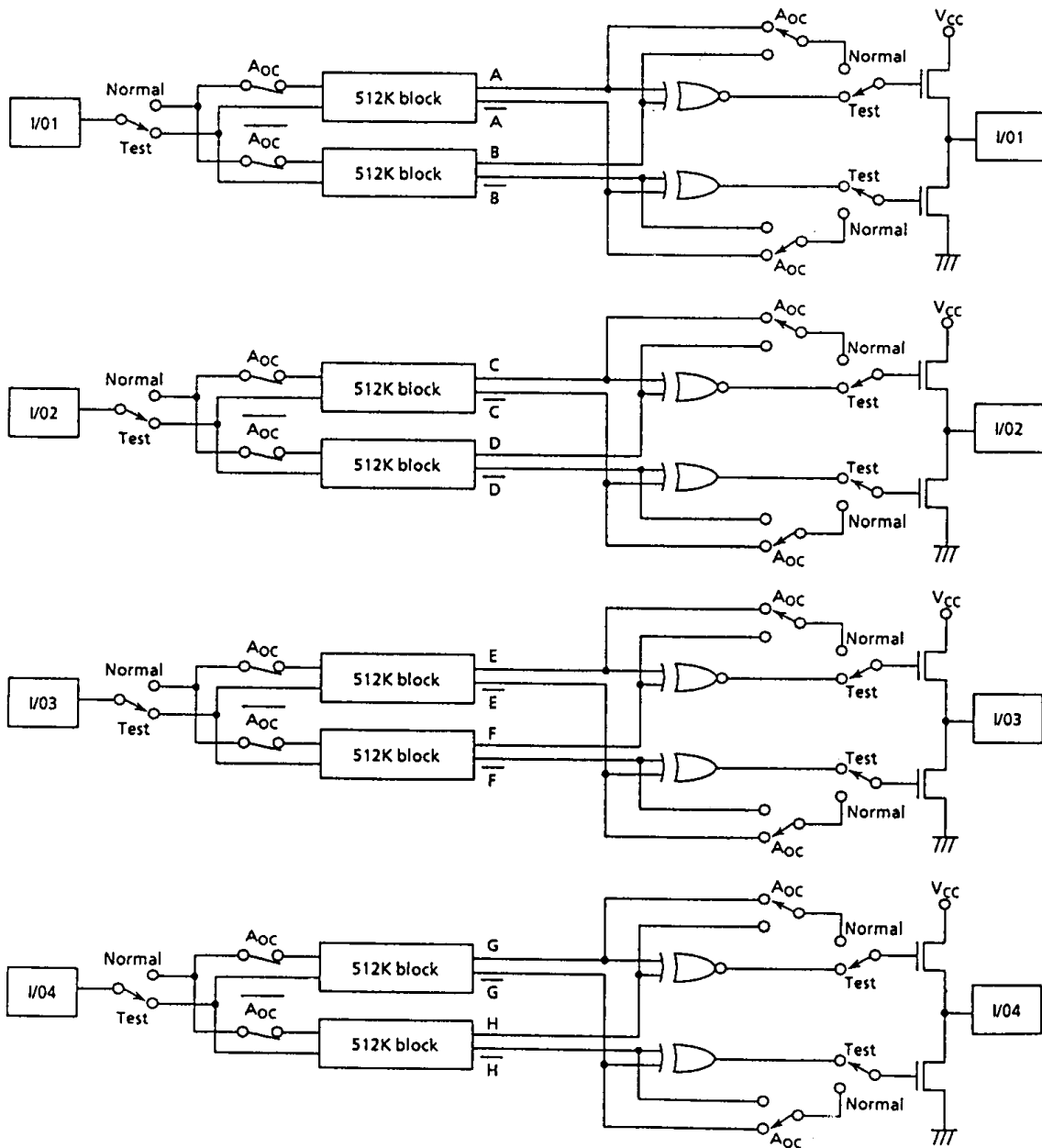


Fig. 1